

**Notice of References Cited**

Application/Control No.

10/564,428

Applicant(s)/Patent Under  
Reexamination  
ECOFF ET AL.

Examiner

M. Lee

Art Unit

2622

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,428,022	09-2008	Teichner et al.	348/725
*	B	US-5,557,617	09-1996	Belcher et al.	370/316
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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